IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

A Applicants:

Taek-Joon JEON et al.

Application No.:

NEW APPLICATION

Filed:

AUGUST 21, 2003

For:

SEMICONDUCTOR TEST SYSTEM AND METHOD OF OPERATING

THE SAME

INFORMATION DISCLOSURE STATEMENT (SUBMISSION CONCURRENT WITH THE FILING OF A NEW PATENT APPLICATION)

August 21, 2003

MAIL STOP NEW APPLICATION COMMISSIONER FOR PATENTS P.O. BOX 1450 Alexandria, Virginia 22313-1450

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. <u>LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION</u>

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

II. COPIES

\boxtimes	Submitted herewith is a legible copy of (i) each U.S. and foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
	This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should be forwarded from the International Search Authority. If copies are needed, please contact the undersigned.

Ш. **CONCISE EXPLANATION OF THE RELEVANCE** (check at least one box) П a. DOCUMENTS IN THE ENGLISH LANGUAGE The attached patents, publications, or other information in the English language do not require a statement of relevancy. \boxtimes DOCUMENTS NOT IN THE ENGLISH LANGUAGE b. A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows: For the Examiner's convenience, Applicants submit herewith an English language Abstract for Korean Patent Application Nos. 1995-37825 and 1996-061594, and Japanese Patent Nos. JP9061491; and JP2001349927 c. **OTHER** For the Examiner's convenience, we attach hereto U.S. Patent No. , which is the corresponding U.S. equivalent of Submission of the English language equivalent(s) is deemed to satisfy the requirement for a concise explanation of relevancy.

FEES

This Information Disclosure Statement is being filed concurrently with the filing of a new patent application; therefore, no fee is required.

If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned. If it is determined that this IDS has been filed under the wrong rule, the PTO is requested to consider this IDS under the proper rule and charge the appropriate fee to Deposit Account No. 08-0750.

New U.S. Application 2557-000158/US

If necessary, the Commissioner is hereby authorized in this, concurrent, and future replies, to charge payment or credit any overpayment to Deposit Account No. 08-0750 for any additional fees required under 37 C.F.R. § 1.16 or under § 1.17; particularly, extension of time fees.

Respectfully submitted,

HARNESS, DICKEY & PIERCE, P.L.C

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JAC:jj

Enclosures: \boxtimes Form PTO-1449(s)

> \boxtimes **Documents**

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Form PTO	0-1449	ATTY DOCKET NO.	APPLICATION NO.												
INFORMATION DISCLOSURE CITATION IN AN APPLICATION			2557-000158/US APPLICANT Taek-Joon JEON et al.		NEW CONF. NO. Unknown										
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	1996-061594	12/4/1996	Republic of Korea			ABST									
	JP9061491	3/7/1997	Japan			ABST									
	JP2001349927	12/21/2001	Japan			ABST									
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